## Notice of References Cited Application/Control No. 10/539,590 Applicant(s)/Patent Under Reexamination DANEAU ET AL. Examiner Mark H. Paschall 3742 Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,215,656	08-1980	Manaka et al.	. 123/688
*	В	US-4,391,256	07-1983	Sawada et al.	60/276
*	C	US-4,109,615	08-1978	Asano, Masaharu	123/686
*	D	US-2003/0019865	01-2003	Whitney et al.	219/497
	Ē.	US-			
	F	U\$-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
,	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					A
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	>	
	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.